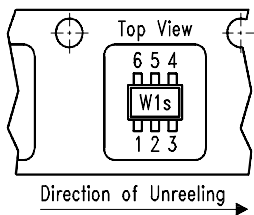
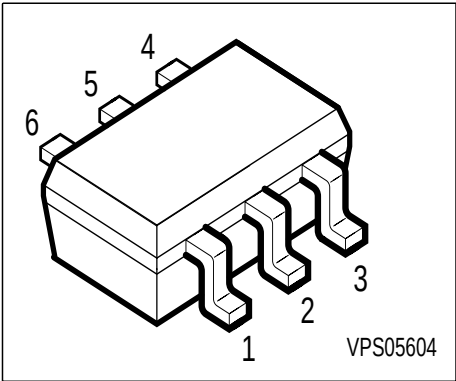


NPN Silicon Switching Transistor Array

Preliminary data

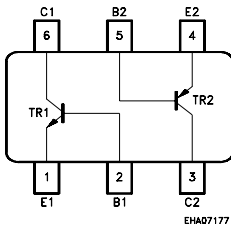
- High current gain
- Low collector-emitter saturation voltage
- Two (galvanic) internal isolated NPN/PNP Transistors in one package



Marking on SOT-363 package (for example W1s) corresponds to pin 1 of device

Position in tape: pin 1 opposite of feed hole side

EHA07193



EHA07177

PIN Configuration

Type	Marking	Ordering Code	Package	NPN-Transistor	1 = E	2 = B	6 = C
SMBT 3904PN	s3P	Q62702-C	SOT-363	PNP-Transistor	4 = E	5 = B	6 = C

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}	40	V
Collector-base voltage	V_{CBO}	40	
Emitter-base voltage	V_{EBO}	6	
DC collector current	I_C	200	mA
Total power dissipation, $T_S = 115\text{ °C}$	P_{tot}	250	mW
Junction temperature	T_j	150	°C
Storage temperature	T_{stg}	- 65...+150	

Thermal Resistance

Junction ambient ¹⁾	R_{thJA}	≤ 275	K/W
Thermal resistance, chip case	R_{thJC}	≤ 140	

1) Package mounted on pcb 40mm x 40mm x 1.5mm / 0.5cm

Electrical Characteristics at $T_A=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics per Transistor					
Collector-emitter breakdown voltage $I_C = 1\text{ mA}$, $I_B = 0$	$V_{(BR)CEO}$	40	-	-	V
Collector-base breakdown voltage $I_C = 10\text{ }\mu\text{A}$, $I_B = 0$	$V_{(BR)CBO}$	40	-	-	
Emitter-base breakdown voltage $I_E = 10\text{ }\mu\text{A}$, $I_C = 0$	$V_{(BR)EBO}$	6	-	-	
Collector cutoff current $V_{CB} = 30\text{ V}$, $I_E = 0$	I_{CBO}	-	-	50	nA
DC current gain 1) $I_C = 100\text{ }\mu\text{A}$, $V_{CE} = 1\text{ V}$ $I_C = 1\text{ mA}$, $V_{CE} = 1\text{ V}$ $I_C = 10\text{ mA}$, $V_{CE} = 1\text{ V}$ $I_C = 50\text{ mA}$, $V_{CE} = 1\text{ V}$ $I_C = 100\text{ mA}$, $V_{CE} = 1\text{ V}$	h_{FE}	40 70 100 60 30	- - - - -	- - 300 - -	-
Collector-emitter saturation voltage1) $I_C = 10\text{ mA}$, $I_B = 1\text{ mA}$ $I_C = 50\text{ mA}$, $I_B = 5\text{ mA}$	V_{CEsat}	- -	- -	0.25 0.4	V
Base-emitter saturation voltage 1) $I_C = 10\text{ mA}$, $I_B = 1\text{ mA}$ $I_C = 50\text{ mA}$, $I_B = 5\text{ mA}$	V_{BEsat}	0.65 -	- -	0.85 0.95	

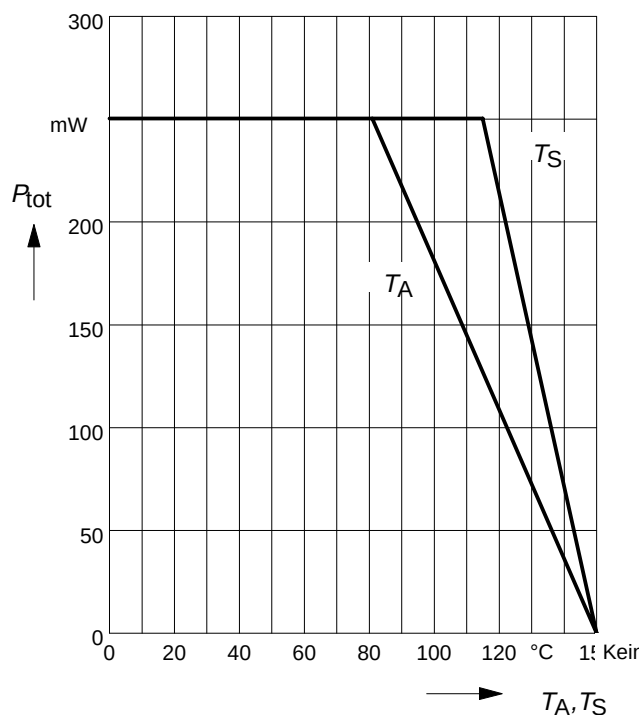
1) Pulse test: $t < 300\mu\text{s}$; $D < 2\%$

Electrical Characteristics at $T_A=25^\circ\text{C}$, unless otherwise specified

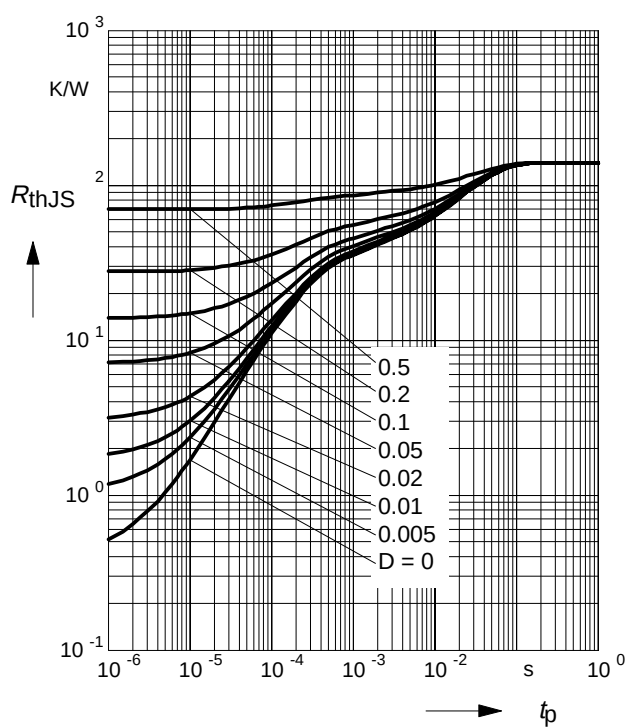
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics per Transistor					
Transition frequency $I_C = 10\text{ mA}$, $V_{CE} = 5\text{ V}$, $f = 100\text{ MHz}$	f_T	250	-	-	MHz
Collector-base capacitance $V_{CB} = 10\text{ V}$, $f = 1\text{ MHz}$	C_{cb}	-	-	4.5	pF
Emitter-base capacitance $V_{EB} = 0.5\text{ V}$, $f = 1\text{ MHz}$	C_{eb}	-	-	10	
Short-circuit input impedance $I_C = 2\text{ mA}$, $V_{CE} = 5\text{ V}$, $f = 1\text{ kHz}$	h_{11e}	2	-	12	kΩ
Open-circuit reverse voltage transfer ratio $I_C = 2\text{ mA}$, $V_{CE} = 5\text{ V}$, $f = 1\text{ kHz}$	h_{12e}	0.1	-	10	10 ⁻⁴
Short-circuit forward current transfer ratio $I_C = 2\text{ mA}$, $V_{CE} = 5\text{ V}$, $f = 1\text{ kHz}$	h_{21e}	100	-	400	-
Open-circuit output admittance $I_C = 2\text{ mA}$, $V_{CE} = 5\text{ V}$, $f = 1\text{ kHz}$	h_{22e}	1	-	60	μs
Noise figure $I_C = 100\text{ μA}$, $V_{CE} = 5\text{ V}$, $R_S = 1\text{ kΩ}$, $f = 1\text{ kHz}$, $\Delta f = 200\text{ Hz}$	F	-	-	5	dB
Delay time $V_{CC} = 3\text{ V}$, $I_C = 10\text{ mA}$, $I_{B1} = 1\text{ mA}$, $V_{BE(off)} = 0.5\text{ V}$	t_d	-	-	35	ns
Rise time $V_{CC} = 3\text{ V}$, $I_C = 10\text{ mA}$, $I_{B1} = 1\text{ mA}$, $V_{BE(off)} = 0.5\text{ V}$	t_r	-	-	35	
Storage time $V_{CC} = 3\text{ V}$, $I_C = 10\text{ mA}$, $I_{B1}=I_{B2} = 1\text{mA}$	t_{stg}	-	-	225	
Fall time $V_{CC} = 3\text{ V}$, $I_C = 10\text{ mA}$, $I_{B1}=I_{B2} = 1\text{mA}$	t_f	-	-	75	

Total power dissipation $P_{\text{tot}} = f(T_A^*; T_S)$

* Package mounted on epoxy

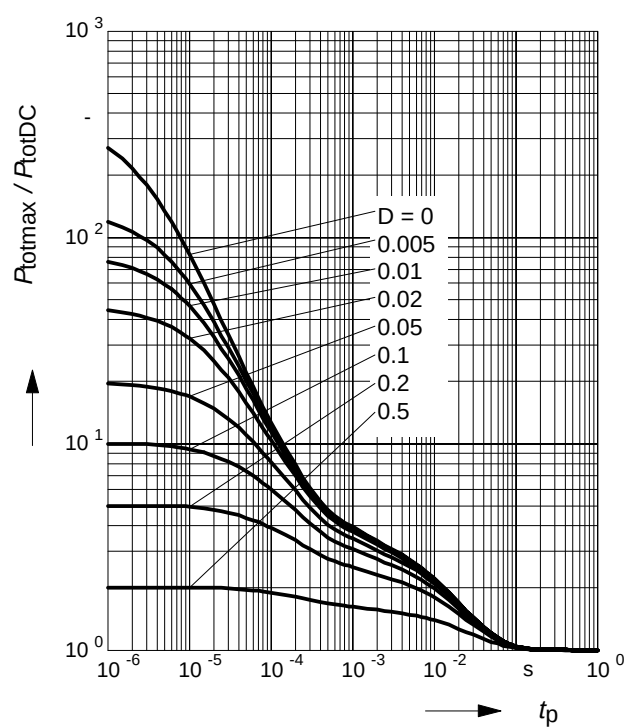


Permissible Pulse Load $R_{\text{thJS}} = f(t_p)$



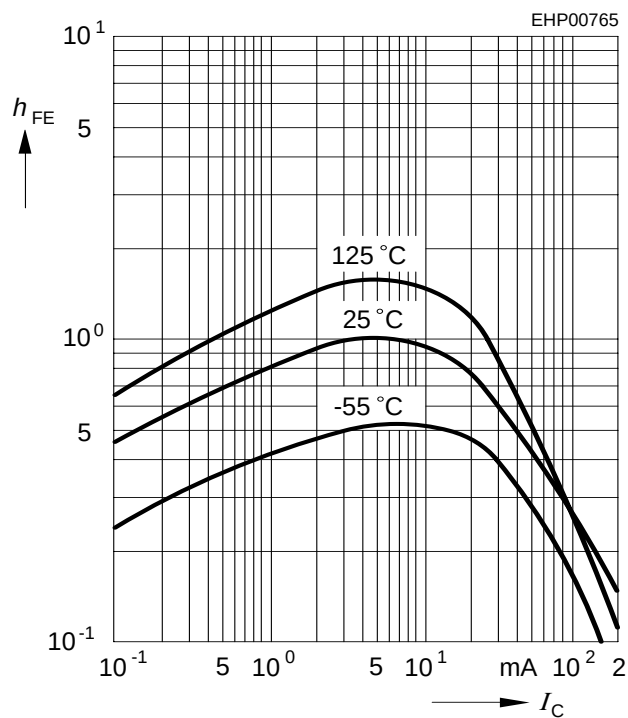
Permissible Pulse Load

$P_{\text{totmax}} / P_{\text{totDC}} = f(t_p)$



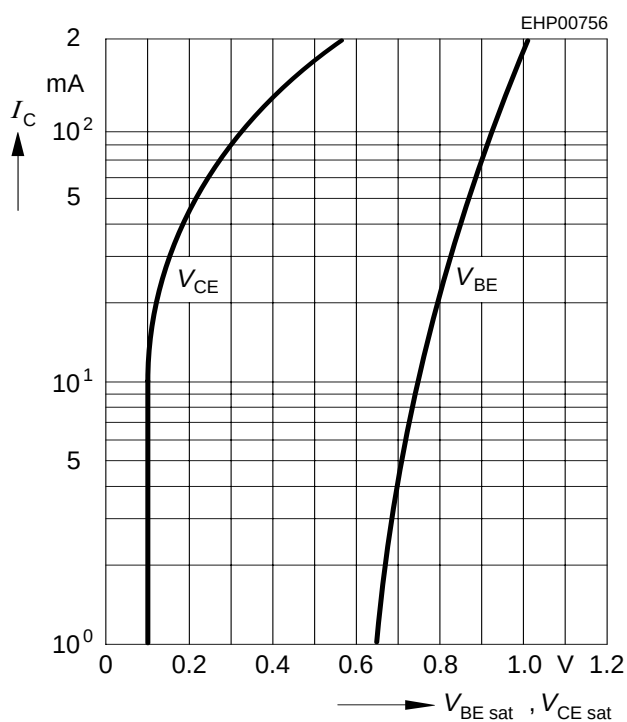
DC current gain $h_{FE} = f(I_C)$

$V_{CE} = 10V$, normalized



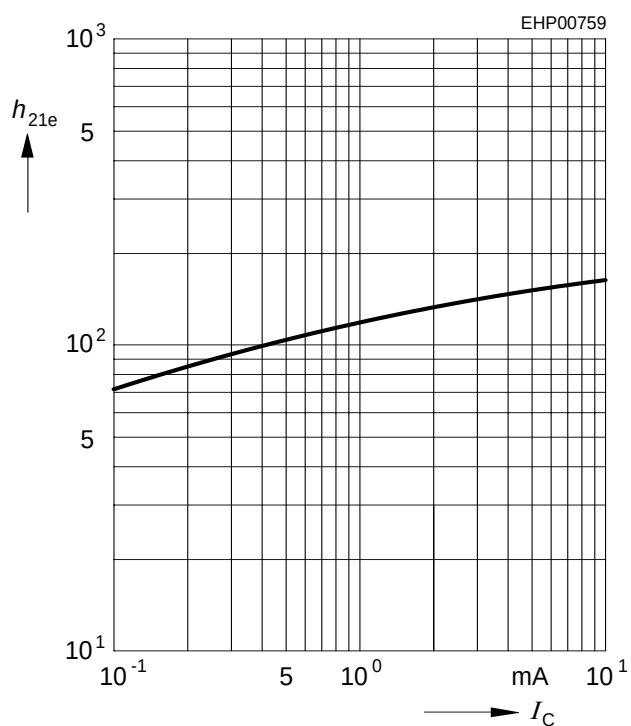
Saturation voltage $I_C = f(V_{BEsat}, V_{CEsat})$

$h_{FE} = 10$



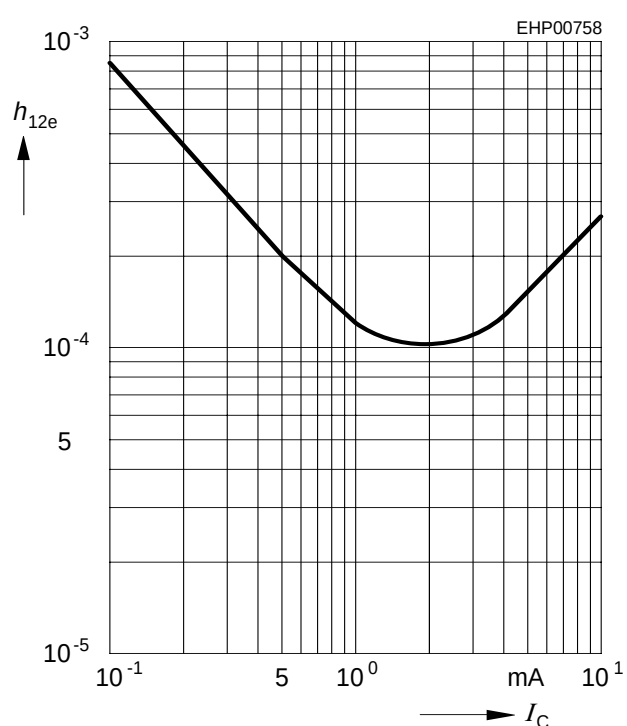
Short-circuit forward current transfer ratio $h_{21e} = f(I_C)$

$V_{CE} = 10V$, $f = 1MHz$



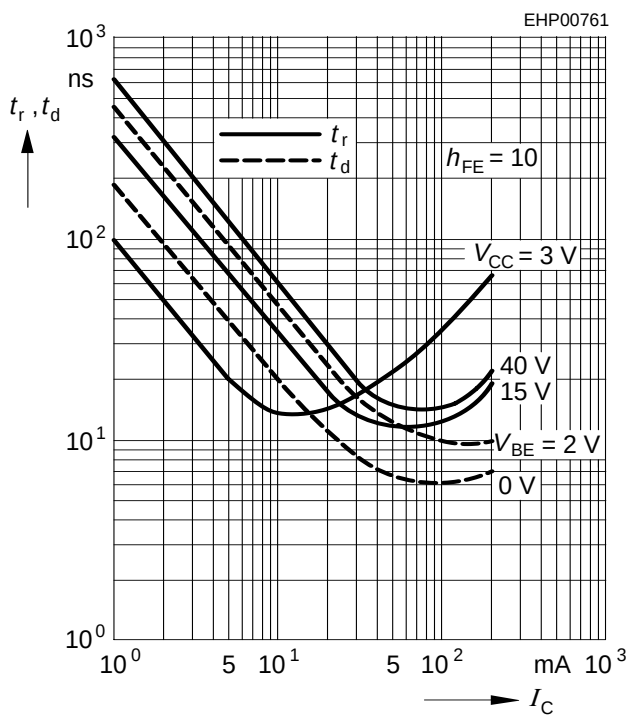
Open-circuit output admittance $h_{22e} = f(I_C)$

$V_{CE} = 10V$, $f = 1MHz$

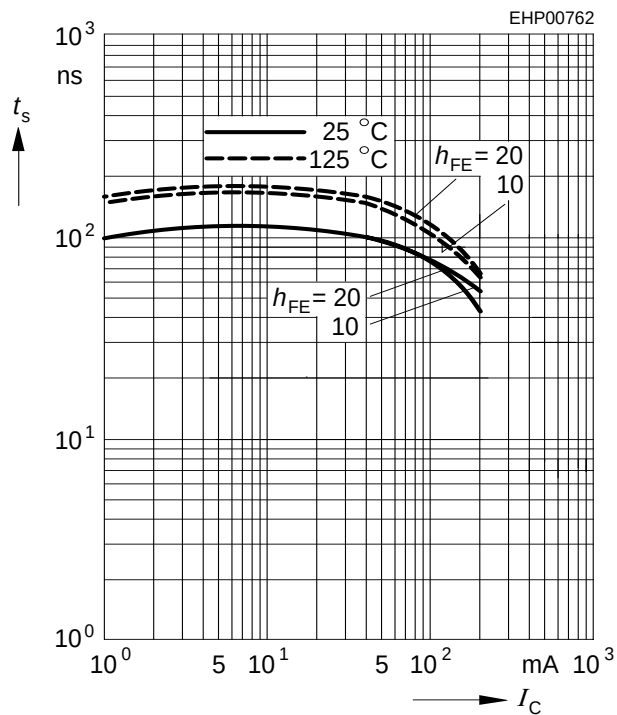


Delay time $t_d = f(I_C)$

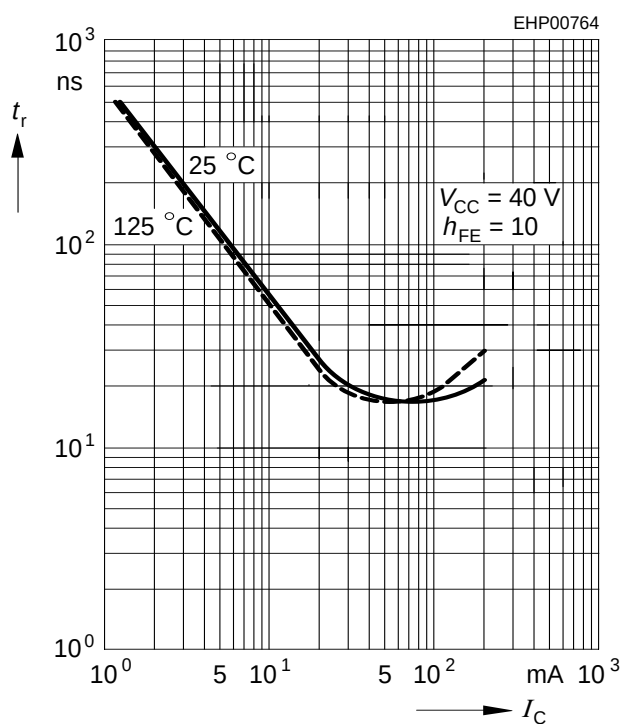
Rise time $t_r = f(I_C)$



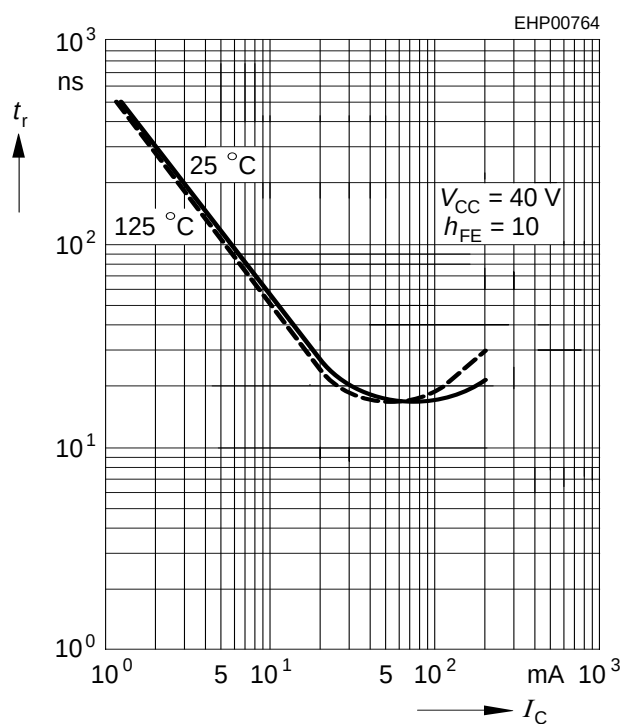
Storage time $t_{stg} = f(I_C)$



Fall time $t_f = f(I_C)$



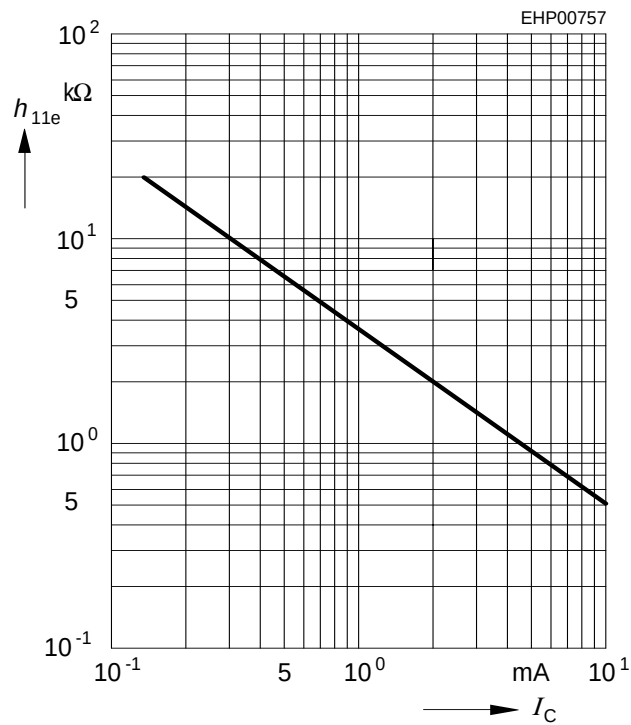
Rise time $t_r = f(I_C)$



Input impedance

$$h_{11e} = f(I_C)$$

$$V_{CE} = 10V, f = 1kHz$$



Open-circuit reverse voltage

$$\text{transfer ratio } h_{12e} = f(I_C)$$

$$V_{CE} = 10V, f = 1kHz$$

